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SPECIFICATIONS

Messrs. 深圳市铭宇泰科技有限公司

Approved by	

Product	CRYSTAL UNIT
Type of Holder	CM315D
Nominal Frequency	32.768 kHz
Customer's Part Number	
Our Part Number	CM315D32768DZCT

SalesCITIZEN FINEDEVICE CO., LTD. Miyota Works. Micro Devices Division.Manufacturer4107-5, MIYOTA, MIYOTA-MACHI, KITASAKU-GUN, NAGANO, 389-0295, JAPAN

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Approved	Checked

CONFIDENTIAL

	Revis	sion	Histo	ory	Date : 20		K-0850 2021/5/31 2 OF 10		
Record	1	Page	Section	Changes	8		Prepared		
Revision number	Date								
1 st	2021/5/31	\angle							

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1. Sco	ре		
	The specifications are applicable to the CITIZEN FINEDEVICE CO., LTD.	e crystal unit to be supplied by	
1	.1 If something defined ambiguously or u Any question arising out of the specific shall be settled through mutual consult	cations or any matter undefined	
1	.2 The specifications does not include pro The contents except electrical specification to change without prior notice.	-	
1	.3 The product is not intended to be incomextremely high reliability such as life s		
2. Elec	ctrical Specifications		
2	.1 Nominal Frequency	32.768 kHz	
2	.2 Operating Temperature Range	$-40 \sim +85 \ ^\circ \mathrm{C}$	
2	.3 Storage Temperature Range	$-55 \sim +125 \ ^\circ \mathrm{C}$	
2	.4 Frequency Tolerance	±20ppm Max. at 25°C	
2	.5 Frequency Tolerance over Operating Temperature Range	Turnover Temp.;25±5 ℃ Temp.Coefficient:-0.034±0.006ppm/℃	
2	.6 Equivalent Series Resistance	70k Ω Max.at 25°C	
2	.7 Insulation Resistance	500M Ω Min./DC100V \pm 15V	
2	.8 Shunt Capacitance	0.95pF Typ	
3. Test	t Conditions		
3	.1 Load Capacitance	9.0pF This Load Capacitance has been fixed request.	on customer's
3	.2 Level of Drive	1µW Max.	

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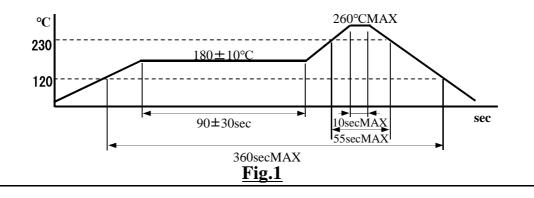
4. Mechanical and Environmental Tests

	Test N		Test Conditions	Criteria No.
	1	cal Tests		-
1-1	Shock		Drop 3 times from the height of 75 cm onto hard wooden board with thickness of 3 cm.	А
1-2	Vibrat	tion	Vibration Frequency : 10 to 500 Hz, 1.5mm, full wave, or acceleration 10G,	
			Cycle : 1.5 minutes, Direction : X.Y.Z.	А
			Time : 2 hours in each direction, for 6 hours in total.	
1-3	Streng	gth	Weight 9.8N on the center of sample with R 0.5 bar 10 seconds.	С
1-4	Solder	ability	After applying RMA flux, dip in solder. Dipping Time : 5 ± 0.5 seconds.	D
			Soldering Temperature : $230\pm5^{\circ}$ C	
1-5	Reflow	v Soldering	See Fig.1 reflow condition.	В
	Heat F	Resistance		
1-6	Sealing	g Tightness	Leak rate shall be measured by using Helium Leak Detector.	Е
2. I	Environ	nmental Te	ists	
2-1	Storag	ge In	Expose the sample in an inoperative mode to 500 hours at -40° C	А
	Low Te	emperature		
2-2	Storag	ge In	Expose the sample in an inoperative mode to 500 hours at $+85^{\circ}$ C	В
	High T	emperature		
2-3	Humic	lity	Expose the sample in an inoperative mode to 500 hours at $+65^{\circ}$ C, and 95% RH.	В
2-4	Therm	al Shock	Subject the sample to 5 temperature variation cycles at -40°C for 30 minutes	А
			and $+100^{\circ}$ C for the next 30 minutes in each cycle.	
Crit	eria			
	eria No.		Criteria	
	А		ion between the pre- and post-test frequencies shall remain within ± 5 ppm.	
			ion between the pre- and post-test the equivalent series resistance shall remain within $\pm 20\%$	or ± 15 k Ω .
	В	-	ion between the pre- and post-test frequencies shall remain within ± 10 ppm.	
			ion between the pre- and post-test the equivalent series resistance shall remain within $\pm 20\%$	or ± 15 k Ω .
	С	-	h test, no visible damage, nor the hermetic seal break down.	
	-	- mer euer		

D At least 90% of each dipped area shall be covered by fresh solder.

E 1×10^{-2} Micro Pa·m³/s Max.

※ Measurements should be taken place at 25±2℃ after each test, the samples shall be left at 25℃ for one to two hours.



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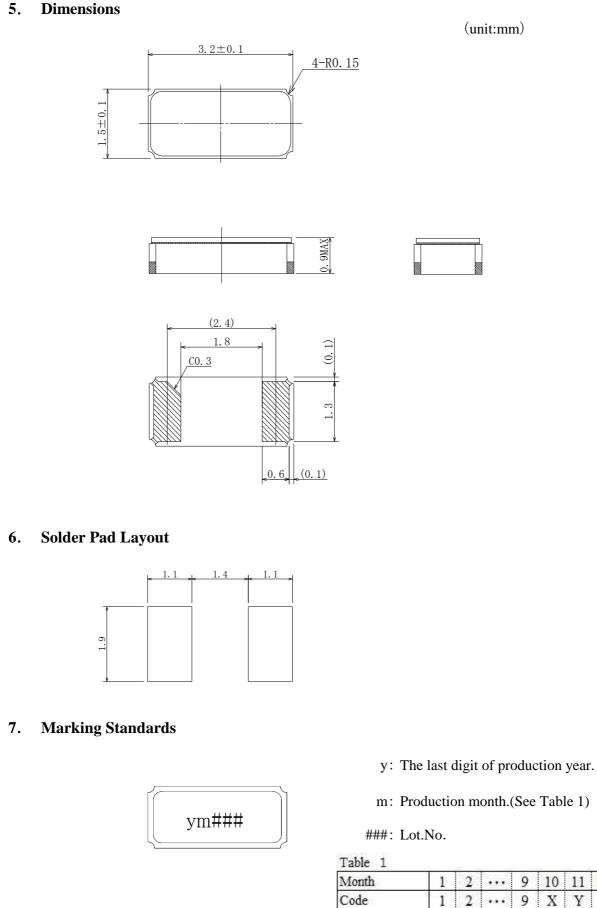
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5. **Dimensions**



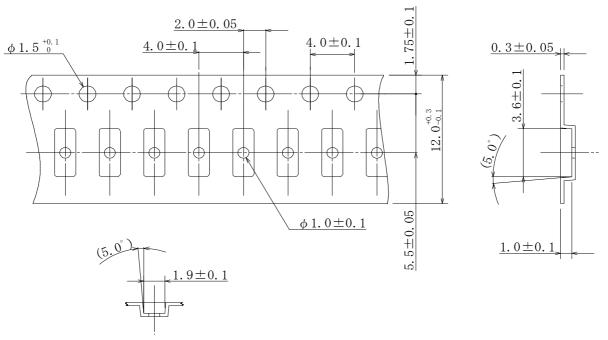
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8. Tape and Reel Packaging

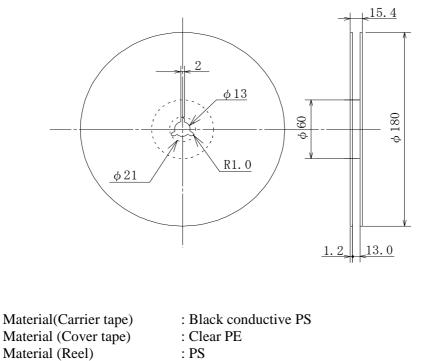
(1) Taping Specification

Conforming to JIS C 0806-3

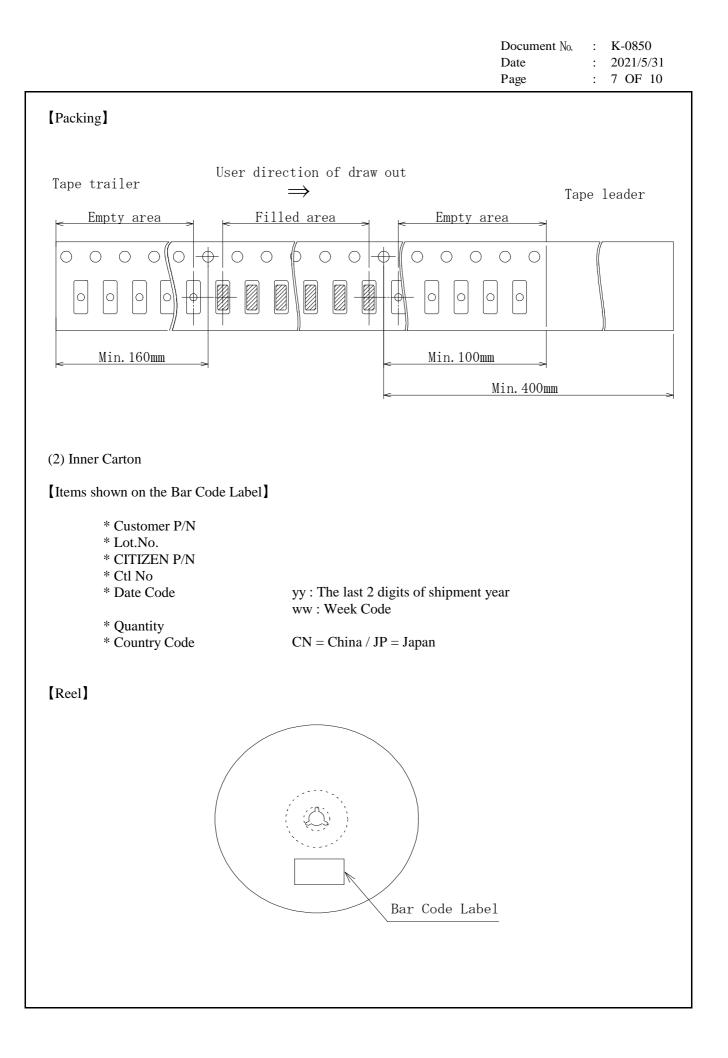
[Tape Dimensions]



[Reel Dimensions]



(unit:mm)



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[Inner Carton fo	or 1 reel			
		Bar Code	e Label	
(3)Quantity				
3000pcs/re	eel			
9. Storage (Condition			
9	.1 Storage Condition	Temperature	$5 \sim 35^{\circ}\mathrm{C}$	
		Humidity	$45\sim75\%$	
9	.2 Warranty Period	Twelve months		
10. Manufac	turer			
(Domestic) CITIZEN FINEDEVICE 4107-5, MIYOTA, MIY TEL : +81-267-31-1111	OTA-MACHI, KITASA	orks. AKU-GUN, NAGANO, 3	389-0295, JAPAI
	Country of Origin:JAPA	N		
(Oversea)	MASTER CROWN ELL No8 BUILDING 137.XI TEL : +86-774-386314	INXING ER ROAD, W	DU) LIMITED. UZHOU, GUANGXI, CI	HINA
	Country of Origin : CHI	NA		
* These m	anufacture are under the co	ntrol of CITIZEN FINE	DEVICE CO., LTD.	
11. Ozone De	epleting Substance (O)	DS)		
This Produ	ict does not use the class I	ODS for any of product	ion processes or for com	ponent parts.

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12. Handling Notes

12-1 When dropped by mistake

The crystal products are designed and manufactured to satisfy the test criteria for shock and vibration. Be sure, however, to check the product's performance before use in the event that they receive excessive shock, for example, by dropping onto the floor.

12-2 Mounting crystal units onto circuit board

When using an automatic loading mounter, test and confirm that no damage has been caused to the characteristics of crystal units before mounting. In case that the boards need to be separated after mounting crystal units, be careful that the bending stress does not affect the product characteristics or solder junction areas.

12-3 Cleaning

- Crystal products may be affected and destroyed at worst by ultrasonic cleaning. Be sure that your cleaning process does not affect the functionality of crystal product prior to use.
- (2) The use of inappropriate cleaning fluid may cause damages to crystal products. Please be sure to check suitability of the cleaning fluid in advance.

12-4 Storage

Storage of crystal products under higher temperature or high humidity for a long term may affect frequency stability or solderability. Be sure to store the products under the normal temperature and humidity without exposing to direct sunlight and dew condensation. Storage period should be within 6 months if possible, and mount the products as soon as possible after unpacking.

12-5 Replacement

If the defect is caused by our company within 12 months from the delivery time, we provide the replacement free of charge.

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13. Note

- 13-1 CITIZEN FINEDEVICE CO., LTD. does not assume any liability for any defect arising from improper use of the product beyond the specifications provided.
- 13-2 CITIZEN FINEDEVICE CO., LTD. does not assume any liability for any damage, loss or infringement of third partys' rights including industrial property rights or other related rights, which may result from the use of the product in this specifications.
- 13-3 The product in this specifications is designed to be used for general electronic equipment, and not intended to be incorporated in any medical equipment or safety control device requiring high reliability, where product defect may threaten human life and body, or may damage a property. CITIZEN FINEDEVICE CO., LTD. may decline your purchase request if the product is planned to be used for such applications, and does not assume any liability for any damages or loss arising from the use for the applications.